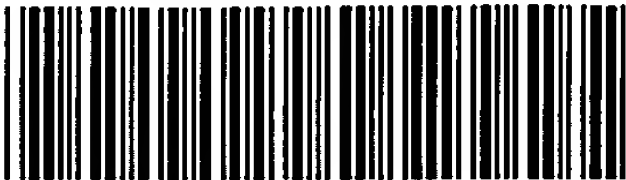


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/980,780	HU ET AL.	
	Examiner	Art Unit	
	Tan V. Mai	2193	

SEARCHED			
Class	Subclass	Date	Examiner
708	403-404,409,321	3/29/2005	MAI

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see attached copy)	3/29/2005	MAI